

Sheet 1 of 1

FORM PTO-144 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. H-1132	SERIAL NO. 10/796,175
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT H. ARAKAWA et al	
		FILING DATE March 10, 2004	GROUP 2165

## U.S. PATENT DOCUMENTS

* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
<i>W</i>	AA	2005/ 0102554	05/12/05	Zohar	-	-	
	AB	2004/ 0268177	12/30/04	Ji	-	-	
	AC	2004/ 0260972	12/23/04	Ji	-	-	
	AD	2004/ 0250031	12/09/04	Ji	-	-	
	AE	2004/ 0250030	12/09/04	Ji	-	-	
	AF	2005/ 0033828	02/10/05	Watanabe	-	-	
	AG	2003/ 0078903	04/24/03	Kimura	-	-	
	AH	5,603,003	02/11/97	Akizawa	-	-	
	AI	5,404,548	04/04/95	Nishioka	-	-	
	AJ	2005/ 0120092	06/02/05	Nakano	-	-	
<i>W</i>	AK	2002/ 0078296	06/20/02	Nakamura	-	-	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
<i>W</i>	AL	06-149485	05/27/94	JP (with English Abstract)	-	-	<input type="checkbox"/>	<input type="checkbox"/>
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	AN						<input type="checkbox"/>	<input type="checkbox"/>
	AO						<input type="checkbox"/>	<input type="checkbox"/>
	AP						<input type="checkbox"/>	<input type="checkbox"/>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	
	AS	
	AT	

EXAMINER <i>W</i>	DATE CONSIDERED 11/7/05
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\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 809; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.


Sheet 1 of 1FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
H-1132SERIAL NO.  
10/796,175**LIST OF DOCUMENTS CITED BY APPLICANT**  
(Use several sheets if necessary)APPLICANT  
H. ARAKAMA et al.FILING DATE  
March 10, 2004GROUP  
2161**U.S. PATENT DOCUMENTS**

* EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA					
	AB					
	AC					
	AD					
	AE					
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	AG					
	AH					
	AI					
	AJ					
	AK					

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
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	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, etc.)

	AR	SDRF/Asynchronous: A Technical Description, EMC White Paper, EMC Corporation, Feb. 2004, pages 1-13.
	AS	
	AT	

EXAMINER

DATE CONSIDERED

\* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.